Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,911	OHWE, TAKESHI	
Examiner	Art Unit	
David D. Davis	2652	

SEARCHED						
Class	Subclass	Date	Examiner			
360	235.8	3/20/2005	DDD			
360	236.6	3/20/2005	DDD			
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INI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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